

Search Notes

Application/Control No.

10/712,347

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2628

SEARCHED

Class	Subclass	Date	Examiner
345	440	5/20/2006	PN
	619	5/20/2006	PN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST search waveform, oscilloscope, editor)	5/20/2006	PN
Nonpatent Literature (IEEE, ACM) search waveform, oscilloscope, editor)	5/20/2006	PN
Inventor Name search	5/20/2006	PN